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Key indicators

Single-crystal X-ray study Mean $\sigma(C-C) = 0.010 \text{ Å}$ Disorder in main residue R factor = 0.035 wR factor = 0.108 Data-to-parameter ratio = 9.4

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

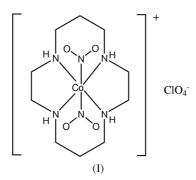
trans-Dinitro(1,4,8,11-tetraazacyclotetradecane-*N*,*N*′,*N*′′,*N*′′′)cobalt(III) perchlorate

In the title compound, trans-[Co(NO₂)₂(cyclam)]ClO₄, (I), where cyclam is 1,4,8,11-tetraazacyclotetradecane ($C_{10}H_{24}N_4$), the Co^{III} complex has a distorted octahedral coordination. The O atoms of each nitro ligand are disordered over two sites with 65:35% occupancy.

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Comment

In the title compound, (I), the Co-NO₂ bond distances are 1.962 (5) and 1.968 (5) Å. The Co-N bond distances of the cyclam are 1.974 (5)-1.986 (4) Å.



Experimental

The title compound, (I), was obtained as a by-product in the synthesis of trans-[Co(cyclam)(NCS)(NO2)]ClO4 from the reaction of trans-[Co(cyclam)(NCS)Cl]ClO₄ (0.5 mmol) with NaNO₂ (1.5 mmol) in 30 ml 0.03 M HNO₃. Crystals of (I) were grown from a dimethyl sulfoxide solution by a diffusion of diethyl ether vapour.

Crystal data

 $[Co(NO_2)_2(C_{10}H_{24}N_4)]ClO_4$ Mo $K\alpha$ radiation $M_r = 450.72$ Cell parameters from 25 Orthorhombic, P2₁2₁2₁ reflections a = 13.299 (3) Å $\theta=10.3\text{--}13.9^\circ$ $\mu = 1.19 \text{ mm}^{-1}$ b = 19.820 (1) Åc = 6.6531 (7) ÅT = 297 (1) K $V = 1753.7 (5) \text{ Å}^3$ Plate, orange $0.40 \times 0.25 \times 0.05 \text{ mm}$ Z = 4 $D_x = 1.707 \text{ Mg m}^{-3}$

Data collection

 $R_{\rm int}=0.024$ Rigaku AFC-7R diffractometer $\theta_{\rm max}=27.5^\circ$ θ –2 θ scans Absorption correction: by integra $h = -17 \rightarrow 8$ tion (Coppens et al., 1965) $k = 0 \rightarrow 25$ $l = -4 \rightarrow 8$ $T_{\min} = 0.752, T_{\max} = 0.942$ 3312 measured reflections 3 standard reflections 2554 independent reflections every 150 reflections 2245 reflections with $I > 2\sigma(I)$ intensity decay: none

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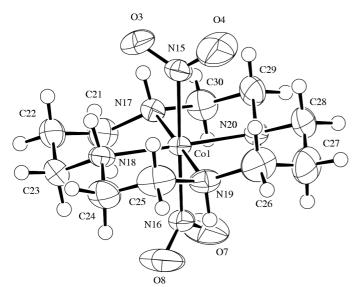


Figure 1 The structure of the complex cation in (I). Displacement ellipsoids are plotted at the 50% probability level. The disordered nitro O atoms with 35% occupancy have been omitted for clarity.

Refinement

Refinement on F^2 R(F) = 0.035 $wR(F^2) = 0.108$ S = 1.08 2554 reflections 271 parameters H-atom parameters constrained $w = 1/[\sigma^{2}(F_{o}^{2}) + (0.0410P)^{2} + 3.4475P]$ where $P = (F_{o}^{2} + 2F_{c}^{2})/3$ $(\Delta/\sigma)_{\text{max}} = 0.001$ $\Delta\rho_{\text{max}} = 0.41 \text{ e Å}^{-3}$ $\Delta\rho_{\text{min}} = -0.55 \text{ e Å}^{-3}$ Absolute structure: (Flack, 1983), 225 Friedel pairs
Flack parameter = -0.05 (4)

X-ray intensities were measured for $\pm h, +k, \pm l$ ($\theta < 15^{\circ}$) and -h, +k, +l ($15 < \theta < 27.5^{\circ}$). The O atoms of the nitro ligands show positional disorder (atoms O3–O10), suggesting that there are two possible orientations with 65:35% occupancy for each NO₂ group. All H-atom positional parameters were calculated geometrically and fixed with $U_{\rm iso}({\rm H}) = 1.2 U_{\rm eq}({\rm parent\ atom})$.

Data collection: *WinAFC* (Rigaku Corporation, 1999); cell refinement: *WinAFC*; data reduction: *TEXSAN* (Molecular Structure Corporation, 1999); program(s) used to solve structure: *SIR*92 (Altomare *et al.*, 1994); program(s) used to refine structure: *SHELXL*97 (Sheldrick, 1997); molecular graphics: *ORTEPII* (Johnson, 1976); software used to prepare material for publication: *TEXSAN*.

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